## Notice of References Cited Application/Control No. 10/562,069 Examiner David Buttner Applicant(s)/Patent Under Reexamination ARAKAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,933,345	08-2005	Lichtenhan et al.	525/101
*	В	US-5,554,702	09-1996	Bell et al.	525/463
	С	US-			
	D	US-			
	E	US-		,	
	F	US-			
	G	US-			
	Ι	US-			
	_	US-			
,	7	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	N					
	0					
	P					
	Q					
	R		-			
	S					
	Т		·			

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>v</b>	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.